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LMK61PD0A2 Ultra-Low Jitter Pin Selectable Oscillator

Technical [Documents](http://www.ti.com/product/LMK61PD0A2?dcmp=dsproject&hqs=td&#doctype2)

- Ultra-low Noise, High Performance
	-
	-
- -
	-
-
- Internal memory stores multiple start-up configurations, selectable through pin control **Device Information[\(1\)](#page-0-0)**
- 3.3V operating voltage **PART NUMBER PACKAGE BODY SIZE (NOM)**
- Industrial temperature range $(-40^{\circ}C)$ to $+85^{\circ}C$)
-

2 Applications

- High-performance replacement for crystal-, SAW-, or silicon-based Oscillators
- Switches, Routers, Network Line Cards, Base Band Units (BBU), Servers, Storage/SAN
- Test and Measurement
- Medical Imaging
- FPGA, Processor Attach

 $OS | 2 |$ $| 5 |$ OUTN

2 5

 $GND \mid 3 \mid 4 \mid OUTP$

3 4

8

FS0

 OE 1 \rightarrow 16 VDD

1 6

7

FS1

Pinout and Simplified Block Diagram

1 Features 3 Description

Tools & **[Software](http://www.ti.com/product/LMK61PD0A2?dcmp=dsproject&hqs=sw&#desKit)**

The LMK61PD0A2 is an ultra-low jitter PLLatinumTM pin selectable oscillator that generates commonly $-$ Jitter: 90 fs RMS typical f_{OUT} > 100 MHz

used reference clocks. The device is pre-

PSRR: -70 dBc, robust supply noise immunity programmed in factory to support seven unique programmed in factory to support seven unique • Flexible Output Frequency and Format; User reference clock frequencies that can be selected by Selectable **pin-strapping each of FS[1:0] to VDD, GND or NC** (no connect). Output format is selected between – Frequencies: 62.5 MHz, 100 MHz, 106.25 LVPECL, LVDS, or HCSL by pin-strapping OS to
MHz, 125 MHz, 156.25 MHz, 212.5 MHz, 2000 CND GND or NC. Internal nower conditioning provide MHZ, 125 MHz, 156.25 MHZ, 212.5 MHZ, VDD, GND or NC. Internal power conditioning provide
312.5 MHz
excellent power supply ripple rejection (PSRR) excellent power supply ripple rejection (PSRR), – Formats: LVPECL, LVDS or HCSL reducing the cost and complexity of the power Total frequency tolerance of \pm 50 ppm delivery network. The device operates from a single $3.3 \text{ V} \pm 5\%$ supply.

• 7 mm x 5 mm 8-pin package (1) For all available packages, see the orderable addendum at the end of the data sheet.

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Table 2. Output Type Mapping for OS, OE Selection

EXAS ISTRUMENTS

6 Pin Configuration and Functions

Table 3. Pin Functions

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

(1) JEDEC document JEP155 states that 500 V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250 V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

7.4 Thermal Information

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953.](http://www.ti.com/lit/pdf/spra953)

(2) The package thermal resistance is calculated on a 4 layer JEDEC board.

(3) Connected to GND with 3 thermal vias (0.3-mm diameter).
(4) ψ JB (junction to board) is used when the main heat flow is (4) ψJB (junction to board) is used when the main heat flow is from the junction to the GND pad. Please refer to Thermal Considerations section for more information on ensuring good system reliability and quality.

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7.5 Electrical Characteristics - Power Supply(1)

VDD = 3.3 V \pm 5%, T_A = -40C to 85°C

(1) Refer to Parameter Measurement Information for relevant test conditions.

(2) On-chip power dissipation should exclude 40 mW, dissipated in the 150 ohm termination resistors, from total power dissipation.

7.6 LVPECL Output Characteristics(1)

VDD = 3.3 V \pm 5%, T_A = -40C to 85°C

(1) Refer to Parameter Measurement Information for relevant test conditions.

(2) An output frequency over f_{OUT} max spec is possible, but output swing may be less than V_{OD} min spec.

(3) Ensured by characterization.

7.7 LVDS Output Characteristics(1)

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

(1) An output frequency over f_{OUT} max spec is possible, but output swing may be less than V_{OD} min spec.

(2) Ensured by characterization.

7.8 HCSL Output Characteristics(1)

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

(1) Refer to Parameter Measurement Information for relevant test conditions.

(2) Measured from -150 mV to +150 mV on the differential waveform with the 300 mVpp measurement window centered on the differential zero crossing.

(3) Ensured by design.

(4) Ensured by characterization.

7.9 OE Input Characteristics

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

7.10 OS, FS[1:0] Input Characteristics

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

7.11 Frequency Tolerance Characteristics(1)

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

(1) Ensured by characterization.

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TRUMENTS

XAS

7.12 Power-On/Reset Characteristics (VDD)

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

(1) Ensured by characterization.

(2) Ensured by design.

7.13 PSRR Characteristics(1)

VDD = 3.3 V, $T_A = 25^{\circ}C$, FS[1:0] = NC, NC

(1) Refer to Parameter Measurement Information for relevant test conditions.
(2) Measured max spur level with 50 mVpp sinusoidal signal between 50 kHz

Measured max spur level with 50 mVpp sinusoidal signal between 50 kHz and 1 MHz applied on VDD pin

(3) DJ_{SPUR} (ps, pk-pk) = $[2*10(SPUR/20) / (\pi* f_{OUT})]^*1e6$, where PSRR or SPUR in dBc and f_{OUT} in MHz.

7.14 PLL Clock Output Jitter Characteristics(1)(2)

VDD = 3.3 V \pm 5%, T_A = -40°C to 85°C

(1) Refer to Parameter Measurement Information for relevant test conditions.

(2) Phase jitter measured with Agilent E5052 signal source analyzer using a (3) Ensured by characterization. Phase jitter measured with Agilent E5052 signal source analyzer using a differential-to-single ended converter (balun or buffer).

Ensured by characterization.

7.15 Additional Reliability and Qualification

Texas **NSTRUMENTS**

7.16 Typical Performance Characteristics

8 Parameter Measurement Information

8.1 Device Output Configurations

Figure 9. HCSL Output DC Configuration during Device Test

Device Output Configurations (continued)

Figure 14. Differential Output Voltage and Rise/Fall Time

9 Detailed Description

9.1 Overview

The LMK61PD0A2 is a pin selectable oscillator that generates commonly used reference clocks, greater than 100 MHz, with less than 200 fs, rms max random jitter.

9.2 Functional Block Diagram

NOTE

Control blocks are compatible with 1.8/2.5/3.3 V I/O voltage levels.

9.3 Feature Description

9.3.1 Device Block-Level Description

The LMK61PD0A2 comprises of an integrated oscillator that includes a 50 MHz crystal, a fractional PLL with integrated VCO. Completing the device is the combination of an integer output divider and a universal differential output buffer. The on-chip ROM contains seven pre-programmed output frequency plans that selects the appropriate settings for the integrated oscillator, PLL blocks and output divider. [Table](#page-2-1) 1 lists the supported output frequency plans that can be selected by pin-strapping FS[1:0] as required. [Table](#page-2-2) 2 lists the supported output types that can be selected by pin-strapping OS and OE as required. The device is powered by on-chip low dropout (LDO) linear voltage regulators and the regulated supply network is partitioned such that the sensitive analog supplies are running from separate LDOs than the digital supplies which use their own LDO. The LDOs provide isolation from any noise in the external power supply rail with a PSRR of better than -70 dBc at 50 kHz to 1 MHz ripple frequencies at 3.3 V device supply.

9.3.2 Device Configuration Control

The LMK61PD0A2 selects an output frequency plan and output type using control pins FS[1:0].

10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

The LMK61PD0A2 is an ultra-low jitter pin selectable oscillator that can be used to provide reference clocks for high-speed serial links resulting in improved system performance.

10.2 Typical Application

10.2.1 Jitter Considerations in Serdes Systems

Jitter-sensitive applications such as 10 Gbps or 100 Gbps Ethernet, deploy a serial link utilizing a Serializer in the transmit section (TX) and a De-serializer in the receive section (RX). These SERDES blocks are typically embedded in an ASIC or FPGA. Estimating the clock jitter impact on the link budget requires understanding of the TX PLL bandwidth and the RX CDR bandwidth.

As can be seen in [Figure](#page-14-0) 15, the pass band region between the TX low pass cutoff and RX high pass cutoff frequencies is the range over which the reference clock jitter adds without any attenuation to the jitter budget of the link. Outside of these frequencies, the SERDES link will attenuate the reference clock jitter with a 20 dB/dec or even steeper roll-off. Modern ASIC or FPGA designs have some flexibility on deciding the optimal RX CDR bandwidth and TX PLL bandwidth. These bandwidths are typically set based on what is achievable in the ASIC or FPGA process node, without increasing design complexity, and on any jitter tolerance or wander specification that needs to be met, as related to the RX CDR bandwidth.

The overall allowable jitter in a serial link is dictated by IEEE or other relevant standards. For example, IEEE802.3ba states that the maximum transmit jitter (peak-peak) for 10 Gbps Ethernet should be no more than 0.28 * UI and this equates to a 27.1516 ps, p-p for the overall allowable transmit jitter.

The jitter contributing elements are made up of the reference clock, generated potentially from a device like LMK61PD0A2, the transmit medium, transmit driver etc. Only a portion of the overall allowable transmit jitter is allocated to the reference clock, typically 20% or lower. Therefore, the allowable reference clock jitter, for a 20% clock jitter budget, is 5.43 ps, p-p.

Jitter in a reference clock is made up of deterministic jitter (arising from spurious signals due to supply noise or mixing from other outputs or from the reference input) and random jitter (usually due to thermal noise and other uncorrelated noise sources). A typical clock tree in a serial link system consists of clock generators and fanout buffers. The allowable reference clock jitter of 5.43 ps, p-p is needed at the output of the fanout buffer. Modern fanout buffers have low additive random jitter (less than 100 fs, rms) with no substantial contribution to the deterministic jitter. Therefore, the clock generator and fanout buffer contribute to the random jitter while the primary contributor to the deterministic jitter is the clock generator. Rule of thumb, for modern clock generators, is to allocate 25% of allowable reference clock jitter to the deterministic jitter and 75% to the random jitter. This amounts to an allowable deterministic jitter of 1.36 ps, p-p and an allowable random jitter of 4.07 ps, p-p. For serial link systems that need to meet a bit error rate (BER) of 10^{-12} , the allowable random jitter in root-meansquare is 0.29 ps, rms. This is calculated by dividing the p-p jitter by 14 for a BER of 10⁻¹². Accounting for random jitter from the fanout buffer, the random jitter needed from the clock generator is 0.27 ps, rms. This is calculated by the root-mean-square subtraction from the desired jitter at the fanout buffer's output assuming 100 fs, rms of additive jitter from the fanout buffer.

With careful frequency planning techniques, like spur optimization (covered in the Spur Mitigation Techniques section) and on-chip LDOs to suppress supply noise, the LMK61PD0A2 is able to generate clock outputs with deterministic jitter that is below 1 ps, p-p and random jitter that is below 0.2 ps, rms. This gives the serial link system with additional margin on the allowable transmit jitter resulting in a BER better than 10⁻¹².

Typical Application (continued)

Figure 15. Dependence of Clock Jitter in Serial Links

11 Power Supply Recommendations

For best electrical performance of LMK61PD0A2, it is preferred to utilize a combination of 10 uF, 1 uF and 0.1 uF on its power supply bypass network. It is also recommended to utilize component side mounting of the power supply bypass capacitors and it is best to use 0201 or 0402 body size capacitors to facilitate signal routing. Keep the connections between the bypass capacitors and the power supply on the device as short as possible. Ground the other side of the capacitor using a low impedance connection to the ground plane. [Figure](#page-16-2) 16 shows the layout recommendation for power supply decoupling of LMK61PD0A2.

12 Layout

12.1 Layout Guidelines

The following sections provides recommendations for board layout, solder reflow profile and power supply bypassing when using LMK61PD0A2 to ensure good thermal / electrical performance and overall signal integrity of entire system.

12.1.1 Ensuring Thermal Reliability

The LMK61PD0A2 is a high performance device. Therefore careful attention must be paid to device configuration and printed circuit board (PCB) layout with respect to power consumption. The ground pin needs to be connected to the ground plane of the PCB through three vias or more, as shown in [Figure](#page-16-2) 16, to maximize thermal dissipation out of the package.

[Equation](#page-16-3) 1 describes the relationship between the PCB temperature around the LMK61PD0A2 and its junction temperature.

 $T_B = T_J - Ψ_{JB} * P$

where

- T_B : PCB temperature around the LMK61PD0A2
- T_J: Junction temperature of LMK61PD0A2
- Ψ_{JB} : Junction-to-board thermal resistance parameter of LMK61PD0A2 (36.7°C/W without airflow)
- P: On-chip power dissipation of LMK61PD0A2 (1)

In order to ensure that the maximum junction temperature of LMK61PD0A2 is below 125°C, it can be calculated that the maximum PCB temperature without airflow should be at 100°C or below when the device is optimized for best performance resulting in maximum on-chip power dissipation of 0.68 W.

12.1.2 Best Practices for Signal Integrity

For best electrical performance and signal integrity of entire system with LMK61PD0A2, it is recommended to route vias into decoupling capacitors and then into the LMK61PD0A2. It is also recommended to increase the via count and width of the traces wherever possible. These steps ensure lowest impedance and shortest path for high frequency current flow. [Figure](#page-16-2) 16 shows the layout recommendation for LMK61PD0A2.

Figure 16. LMK61PD0A2 Layout Recommendation for Power Supply and Ground

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Layout Guidelines (continued)

12.1.3 Recommended Solder Reflow Profile

It is recommended to follow the solder paste supplier's recommendations to optimize flux activity and to achieve proper melting temperatures of the alloy within the guidelines of J-STD-20. It is preferrable for the LMK61PD0A2 to be processed with the lowest peak temperature possible while also remaining below the components peak temperature rating as listed on the MSL label. The exact temperature profile would depend on several factors including maximum peak temperature for the component as rated on the MSL label, Board thickness, PCB material type, PCB geometries, component locations, sizes, densities within PCB, as well solder manufactures recommended profile, and capability of the reflow equipment to as confirmed by the SMT assembly operation.

13 Device and Documentation Support

13.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms](http://www.ti.com/corp/docs/legal/termsofuse.shtml) of [Use.](http://www.ti.com/corp/docs/legal/termsofuse.shtml)

TI E2E™ Online [Community](http://e2e.ti.com) *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design [Support](http://support.ti.com/) *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

13.2 Trademarks

E2E is a trademark of Texas Instruments.

13.3 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.4 Glossary

[SLYZ022](http://www.ti.com/lit/pdf/SLYZ022) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check<http://www.ti.com/productcontent>for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

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PACKAGE MATERIALS INFORMATION

*All dimensions are nominal

PACKAGE OUTLINE

SIA0008B QFM - 1.15 mm max height

QUAD FLAT MODULE

NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

EXAMPLE BOARD LAYOUT

SIA0008B QFM - 1.15 mm max height

QUAD FLAT MODULE

NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

EXAMPLE STENCIL DESIGN

SIA0008B QFM - 1.15 mm max height

QUAD FLAT MODULE

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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